

Search Notes

Application/Control No.

10/729,758

Examiner

Wilson Lee

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

2821

SEARCHED

Class	Subclass	Date	Examiner
315	224	5/1/2006	WL
	225		
	291		
	219		
	307		
	208		
	244		
	247		
	276		
	209.R		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
315	291	5/1/2006	WL
315	307		
315	224		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	5/1/2006	WL